Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/799,786	NAKANO ET AL.
Examiner	Art Unit
Erin D. Chiem	2883

SEARCHED					
Class	Subclass	Date	Examiner		
385	15	6/11/2007	EDC		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
	-			
	search (see history)	6/11/2007	EDC	

SEARCH NO)
	DATE	EXMR
interference search and text search	6/11/2007	EDC
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